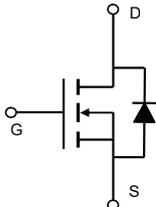


<p><b>Description</b></p> <p>These N-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and with stand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.</p> <p><b>Features</b></p> <ul style="list-style-type: none"> <li>◆ 50V,32A,<math>R_{DS(ON).max}=23m\Omega@V_{GS}=10V</math></li> <li>◆ Improved dv/dt capability</li> <li>◆ Fast switching</li> <li>◆ 100% EAS Guaranteed</li> <li>◆ Green device available</li> </ul> <p><b>Applications</b></p> <ul style="list-style-type: none"> <li>◆ Motor Drives</li> <li>◆ UPS</li> <li>◆ DC-DC Converter</li> </ul>	<p><b>Product Summary</b></p> <table> <tr> <td><math>V_{DSS}</math></td> <td>50V</td> </tr> <tr> <td><math>R_{DS(on).max}@V_{GS}=10V</math></td> <td>23m<math>\Omega</math></td> </tr> <tr> <td><math>I_D</math></td> <td>32A</td> </tr> </table> <p><b>Pin Configuration</b></p> <div style="display: flex; justify-content: space-around;"> <div style="text-align: center;">  <p>TO-252</p> </div> <div style="text-align: center;">  <p>TO-251</p> </div> </div> <div style="text-align: center;">  <p>Schematic</p> </div>	$V_{DSS}$	50V	$R_{DS(on).max}@V_{GS}=10V$	23m $\Omega$	$I_D$	32A
$V_{DSS}$	50V						
$R_{DS(on).max}@V_{GS}=10V$	23m $\Omega$						
$I_D$	32A						

**Absolute Maximum Ratings**  $T_C = 25^\circ C$  unless otherwise noted

Parameter	Symbol	Value	Unit
Drain-Source Voltage	$V_{DSS}$	50	V
Continuous drain current ( $T_C = 25^\circ C$ )	$I_D$	32	A
Continuous drain current ( $T_C = 100^\circ C$ )		20	A
Pulsed drain current <sup>1)</sup>	$I_{DM}$	128	A
Gate-Source voltage	$V_{GSS}$	$\pm 20$	V
Avalanche energy <sup>2)</sup>	$E_{AS}$	25	mJ
Power Dissipation ( $T_C = 25^\circ C$ )	$P_D$	50	W
Storage Temperature Range	$T_{STG}$	-55 to +150	$^\circ C$
Operating Junction Temperature Range	$T_J$	-55 to +150	$^\circ C$

**Thermal Characteristics**

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$	2.5	$^\circ C/W$

## Package Marking and Ordering Information

Device	Device Package	Marking
VSM32N05-T2	TO-252	VSM32N05-T2
VSM32N05-T1	TO-251	VSM32N05-T1

## Electrical Characteristics

 $T_J = 25^\circ\text{C}$  unless otherwise noted

Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit
<b>Static characteristics</b>						
Drain-source breakdown voltage	$BV_{DSS}$	$V_{GS}=0\text{ V}, I_D=250\mu\text{A}$	50	---	---	V
Gate threshold voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	1.0	---	2.0	V
Drain-source leakage current	$I_{DSS}$	$V_{DS}=50\text{ V}, V_{GS}=0\text{ V}, T_J = 25^\circ\text{C}$	---	---	1	$\mu\text{A}$
		$V_{DS}=40\text{ V}, V_{GS}=0\text{ V}, T_J = 125^\circ\text{C}$	---	---	10	$\mu\text{A}$
Gate leakage current, Forward	$I_{GSSF}$	$V_{GS}=20\text{ V}, V_{DS}=0\text{ V}$	---	---	100	nA
Gate leakage current, Reverse	$I_{GSSR}$	$V_{GS}=-20\text{ V}, V_{DS}=0\text{ V}$	---	---	-100	nA
Drain-source on-state resistance	$R_{DS(on)}$	$V_{GS}=10\text{ V}, I_D=15\text{ A}$	---	17	23	m $\Omega$
		$V_{GS}=4.5\text{ V}, I_D=10\text{ A}$	---	21	28	m $\Omega$
Forward transconductance	$g_{fs}$	$V_{DS} = 5\text{ V}, I_D=20\text{A}$	---	52	---	S
<b>Dynamic characteristics</b>						
Input capacitance	$C_{iss}$	$V_{DS} = 25\text{ V}, V_{GS} = 0\text{ V},$ $F = 1\text{MHz}$	---	956	---	pF
Output capacitance	$C_{oss}$		---	80	---	
Reverse transfer capacitance	$C_{rss}$		---	65	---	
Turn-on delay time	$t_{d(on)}$	$V_{DD} = 25\text{V}, V_{GS}=10\text{V}, I_D = 15\text{A}$	---	15	---	ns
Rise time	$t_r$		---	22	---	
Turn-off delay time	$t_{d(off)}$		---	45	---	
Fall time	$t_f$		---	22	---	
Gate resistance	$R_g$	$V_{GS}=0\text{V}, V_{DS}=0\text{V}, F=1\text{MHz}$	---	3.0	---	$\Omega$
<b>Gate charge characteristics</b>						
Gate to source charge	$Q_{gs}$	$V_{DS}=25\text{ V}, I_D=15\text{A},$ $V_{GS}= 10\text{ V}$	---	6.2	---	nC
Gate to drain charge	$Q_{gd}$		---	3.1	---	
Gate charge total	$Q_g$		---	21.5	---	
<b>Drain-Source diode characteristics and Maximum Ratings</b>						
Continuous Source Current	$I_S$		---	---	32	A
Pulsed Source Current <sup>3)</sup>	$I_{SM}$		---	---	128	A
Diode Forward Voltage	$V_{SD}$	$V_{GS}=0\text{V}, I_S=15\text{A}, T_J=25^\circ\text{C}$	---	---	1.2	V
Reverse Recovery Time	$t_{rr}$	$I_S=15\text{A}, di/dt=100\text{A}/\mu\text{s}, T_J=25^\circ\text{C}$	---	17.3	---	ns
Reverse Recovery Charge	$Q_{rr}$		---	4.9	---	nC

### Notes:

1: Repetitive Rating: Pulse width limited by maximum junction temperature.

 2:  $V_{DD}=25\text{V}, V_{GS}=10\text{V}, L=0.5\text{mH}, I_{AS}=10\text{A}, R_G=25\Omega, \text{Starting } T_J=25^\circ\text{C}.$ 

 3: Pulse Test: Pulse Width  $\leq 300\ \mu\text{s}$ , Duty Cycle  $\leq 2\%$ .

## Electrical Characteristics Diagrams

Figure 1. Typ. Output Characteristics

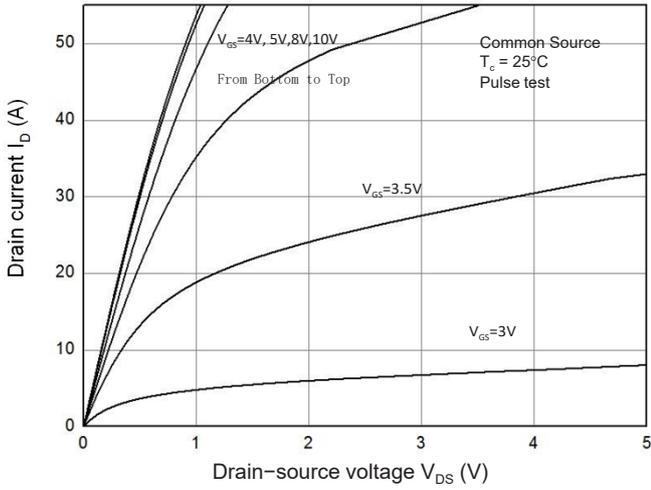


Figure 2. Transfer Characteristics

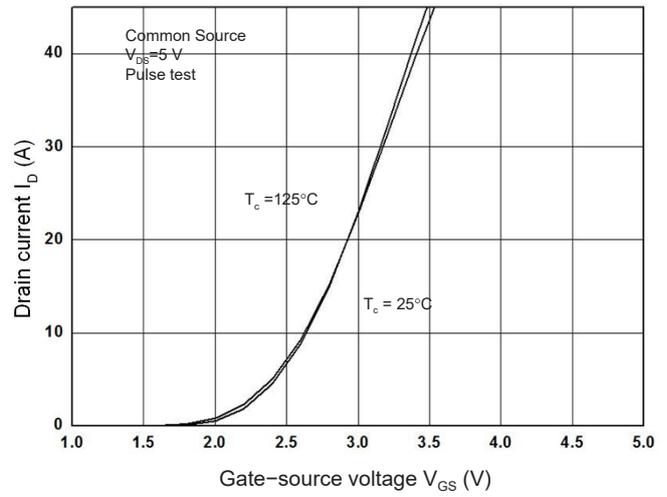


Figure 3. Capacitance Characteristics

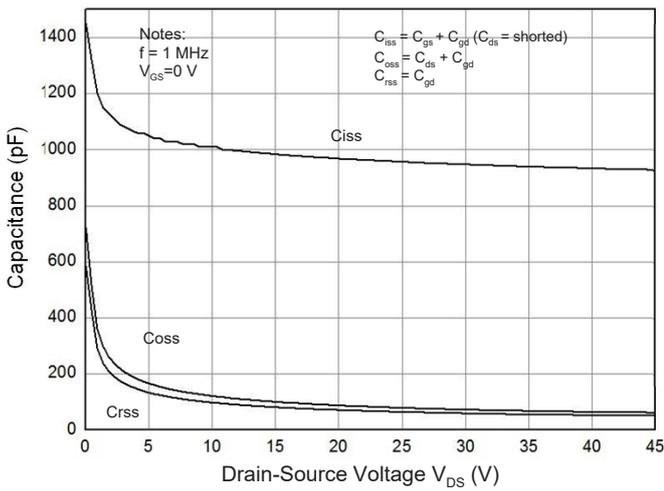


Figure 4. Gate Charge Waveform

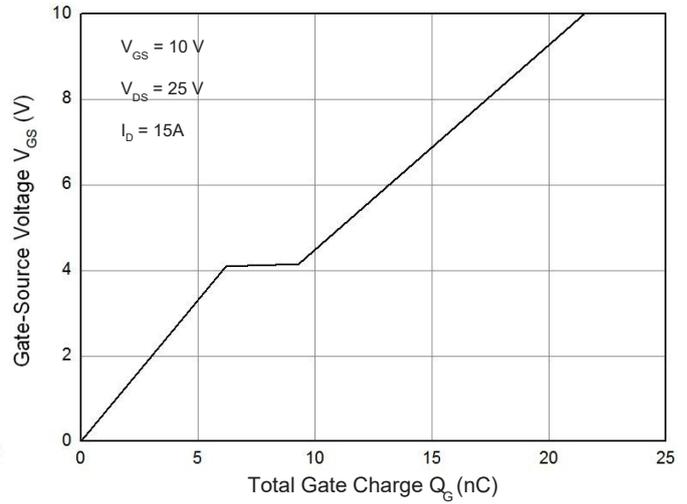


Figure 5. Body-Diode Characteristics

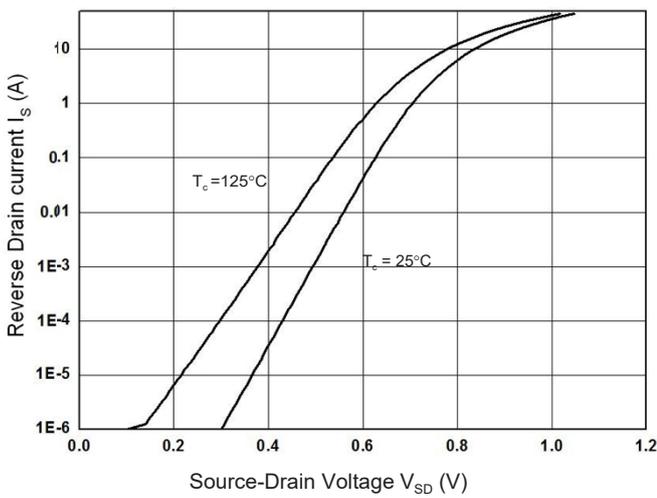


Figure 6. R\_dson-Drain Current

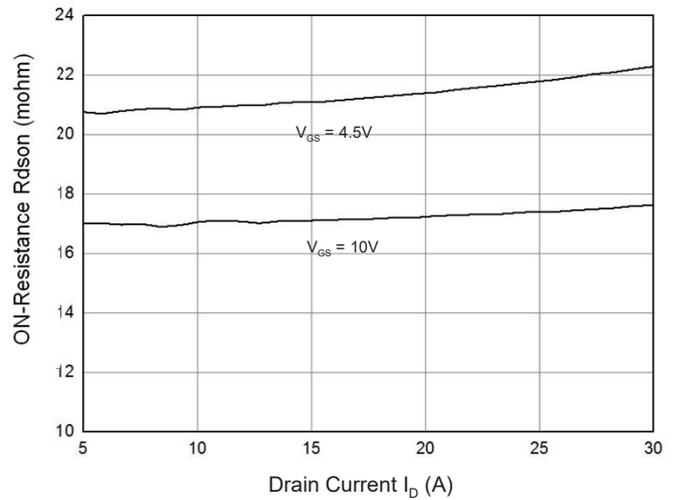


Figure 7. Rdson-Junction Temperature(°C)

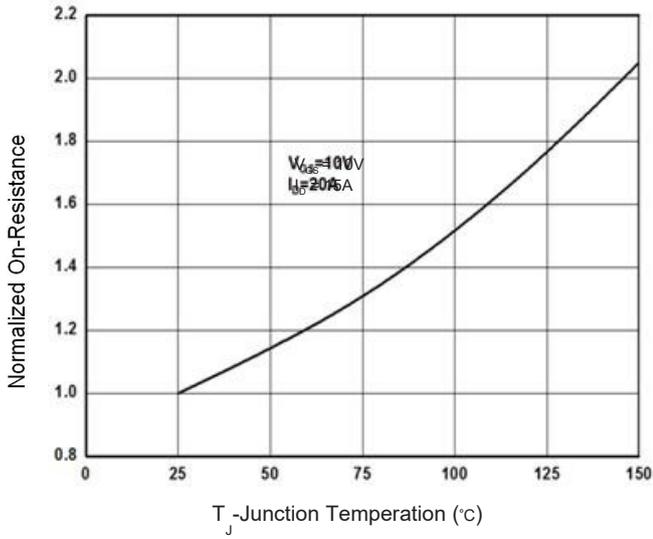


Figure 8. Maximum Safe Operating Area

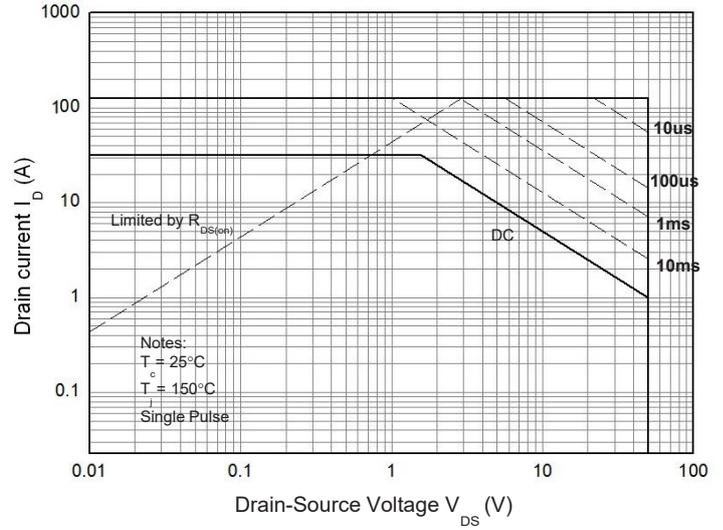
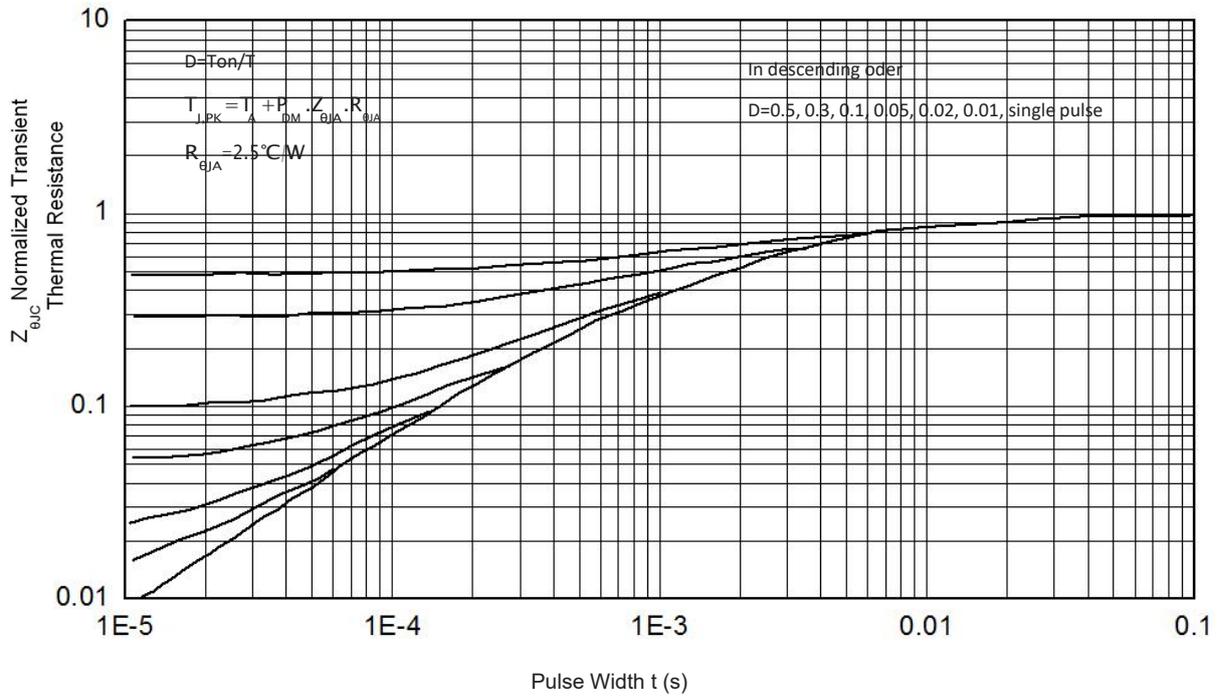


Figure 6. Normalized Maximum Transient Thermal Impedance (RthJC)



**Test Circuit & Waveform**

Figure 8. Gate Charge Test Circuit &amp; Waveform

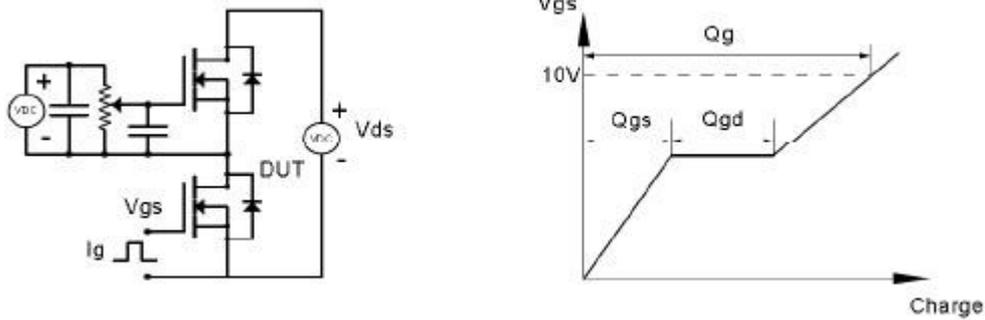


Figure 9. Resistive Switching Test Circuit &amp; Waveforms

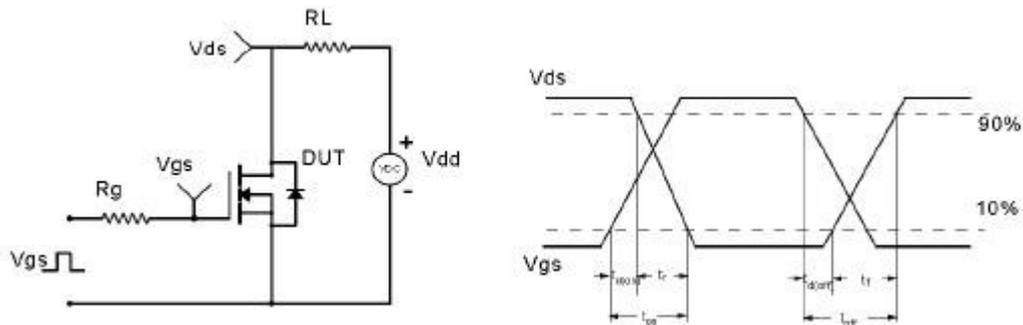


Figure 10. Unclamped Inductive Switching (UIS) Test Circuit &amp; Waveform

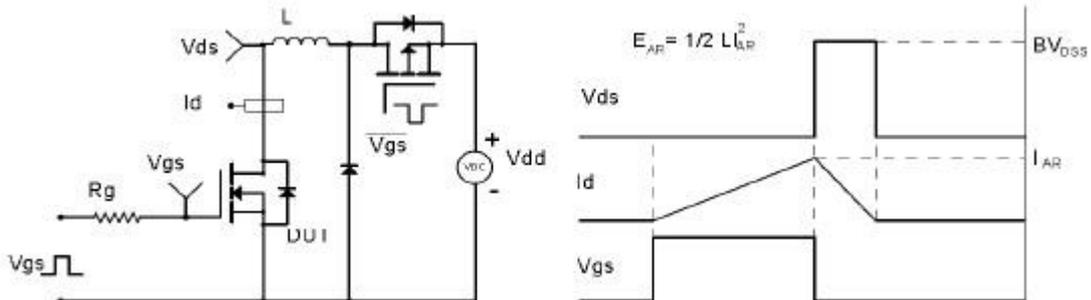


Figure 11. Diode Recovery Circuit &amp; Waveform

